

PDS Spectral Library Data Dictionary

User's Guide

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1 Introduction

1.1 Purpose of this User's Guide

This guide describes the organization and contents of the Spectral Library Data Dictionary, one of several Discipline Dictionaries maintained by the Planetary Data System (PDS). This dictionary is used when creating PDS labels for laboratory spectral data. It contains terms that describe laboratory spectral measurements and the specimens measured.

1.2 Audience

This guide is intended for users and data providers of Spectral Library data products. In particular, users may wish to refer to Section 5, Definitions, to better understand the terms in the PDS labels of data products. Data providers may want to read the entire guide to understand how to create PDS labels for their spectral data.

1.3 Applicable Documents

PDS4 Concepts, <https://pds.nasa.gov/datastandards/documents/concepts/>, a high-level view of the PDS4 archiving standard

The Planetary Data System Standards Reference, <https://pds.nasa.gov/datastandards/documents/sr/current/>, the complete reference for the PDS4 Information Model

The PDS4 Data Dictionary, <https://pds.nasa.gov/datastandards/documents/dd/current/>, the PDS4 core (or "common") dictionary in an easily searchable HTML format

Data Providers' Handbook: Guide to Archiving Planetary Data Using the PDS4 Standard, <https://pds.nasa.gov/datastandards/documents/dph/current/>, a step-by-step guide for creating a PDS archive

The PDS4 Information Model Specification, <https://pds.nasa.gov/datastandards/documents/im/current/>, the same information as in the PDS4 core dictionary, in a formal specification for use by programmers and data engineers

2 Overview of the Spectral Library Data Dictionary

A spectral library is a collection of spectral measurements of laboratory samples, also known as specimens. Specimens may be rocks, minerals, ice, meteorites, etc. They may be in various physical forms. They may be naturally-occurring or synthetic. A given specimen may have many measurements. The measurements may consist of reflectance spectra, Raman spectra, XRD, XRF, LIBS, and other types.

In the PDS Spectral Library, each measurement's data is contained in a single file and is accompanied by a PDS4 label that describes the measurement and the specimen that was measured. Together the data file and PDS4 label are considered one data product.

The Spectral Library Data Dictionary is maintained by Daniel Scholes at the PDS Geosciences Node. It may be revised when new spectra are submitted to the library. Questions about it may be addressed to geosci@wunder.wustl.edu.

3 How to Include the Spectral Library Dictionary in a PDS4 Label

PDS4 labels are written in XML (<https://www.w3.org/XML/>) and are governed by the PDS4 XML schema that defines the label structure and contents. The XML schema not only defines the individual attributes in the label, but also defines the order in which they appear in the label. The main PDS4 XML schema may be supplemented with additional, specialized schemas as needed for particular applications. The Spectral Library Data Dictionary is one such specialized schema.

The schema that defines the main, or "core", PDS4 Dictionary is available at <https://pds.nasa.gov/datastandards/schema/released/#pds>. The schema that defines the Spectral Library Data Dictionary is at <https://pds.nasa.gov/datastandards/schema/released/#speclib>. Here you will see that a dictionary is made up of several files, but only these two are needed for reference in a Spectral Library product label:

PDS4_SPECLIB_xxxx_yyyy.xsd	The schema file itself, containing dictionary definitions. Like PDS labels, the schema file is written in XML. xxxx is the version number of the PDS Core Dictionary and yyyy is the version number of the Spectral Library Data Dictionary.
PDS4_SPECLIB_xxxx_yyyy.sch	The Schematron file, containing rules about the use of dictionary terms, also in XML

The Spectral Library dictionary files are referenced at the beginning of a data product label, as shown in red in this example:

```
<?xml version="1.0" encoding="UTF-8"?>
<?xml-model
  href="https://pds.nasa.gov/pds4/pds/v1/PDS4_PDS_1B00.sch"
  schematypens="http://purl.oclc.org/dsdl/schematron"?>
<?xml-model
  href="https://pds.nasa.gov/pds4/speclib/v1/PDS4_SPECLIB_1B00_1000.sch"
  schematypens="http://purl.oclc.org/dsdl/schematron"?>

<Product_Observational xmlns="http://pds.nasa.gov/pds4/pds/v1"
  xmlns:speclib="http://pds.nasa.gov/pds4/speclib/v1"
  xmlns:xsi="http://www.w3.org/2001/XMLSchema-instance"
  xsi:schemaLocation="http://pds.nasa.gov/pds4/pds/v1
    https://pds.nasa.gov/pds4/pds/v1/PDS4_PDS_1B00.xsd
    http://pds.nasa.gov/pds4/speclib/v1
    https://pds.nasa.gov/pds4/speclib/v1/PDS4_SPECLIB_1B00_1000.xsd">
```

The Spectral Library Data Dictionary defines the metadata terms that describe the data products in the Spectral Library. In a PDS4 data dictionary individual elements are called attributes, and groups of

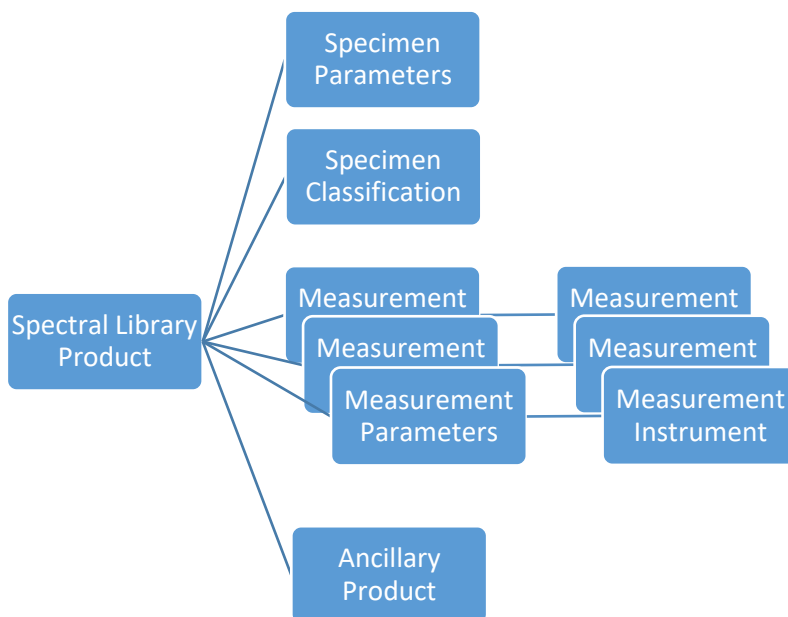
associated attributes are called classes. A class may contain other classes, known as subclasses. The Spectral Library Data Dictionary, referred to in PDS4 labels as "speclib", consists of the top-level **Spectral_Library_Product** class and four subclasses: **Specimen_Parameters**, **Specimen_Classification**, **Measurement_Parameters**, and **Ancillary_Product**. The **Measurement_Parameters** subclass itself has a subclass, **Measurement_Instrument**. This top level class and its subclasses belong in the **Discipline_Area** section of a PDS4 label. For examples of labels of actual products, see section 6.

4 Organization of Classes and Attributes

This section shows the organization of Spectral Library classes and attributes in the order in which they are required to appear in the label. Section 5 lists the attributes and their complete definitions in alphabetical order.

4.1 Class <speclib:Spectral_Library_Product>

Spectral_Library_Product is the superclass that encompasses all other Spectral Library classes and attributes. It has the following structure.



Hierarchy of classes in the Spectral Library Product superclass

This structure is expressed in the label as shown below. Note that the **Spectral_Library_Product** class includes two attributes that are not in a subclass: **processing_description** and **measurement_segments**. It is possible for a spectral measurement to be made up of multiple spectra measured by different instruments. The attribute **processing_description** explains this set of measurements for a given spectrum. The attribute **measurement_segments** gives the number of individual spectra that were combined to create a final merged spectrum. If the spectrum is not merged from multiple segments, then the value of **measurement_segments** is 1. For each segment, a separate instance of the **Measurement_Parameters** class is provided.

```

<speclib:Spectral_Library_Product>
  <speclib:processing_description>
    [processing_description text]
  </speclib:processing_description>
  <speclib:Specimen_Parameters>
    [Specimen_Parameters attributes]
  </speclib:Specimen_Parameters>
  <speclib:Specimen_Classification>
    [Specimen_Classification attributes]
  </speclib:Specimen_Classification>
  <speclib:measurement_segments>2</speclib:measurement_segments>
  <speclib:Measurement_Parameters>
    [Measurement_Parameters attributes for the first segment]
  </speclib:Measurement_Parameters>
  <speclib:Measurement_Parameters>
    [Measurement_Parameters attributes for the second segment]
  </speclib:Measurement_Parameters>
  <speclib:Ancillary_Product>
    [Ancillary_Product attributes]
  </speclib:Ancillary_Product>
</speclib:Spectral_Library_Product>

```

The four classes **Specimen_Parameters**, **Specimen_Classification**, **Measurement_Parameters**, and **Ancillary_Product** are described in the sections that follow. The **Ancillary_Product** section is optional; all others are required, and they must appear in the order shown.

The table below describes each component of the **Spectral_Library_Product** class. Asterisks (*) indicate required components. More complete definitions are in Section 5. Throughout this document class names are given with each word capitalized and attribute names are given in all lowercase, following PDS custom.

Spectral_Library_Product Class	
Component	Description
processing_description	The processing_description attribute provides information about how measurement(s) for a particular data product were made, in addition to the information given in the Measurement_Parameters class. In the case of a product created by merging multiple measurements, this attribute describes how the merge was done. The description can be as long as necessary.
*Specimen_Parameters Class	The Specimen_Parameters class provides information that describes the specimen (sample) that was analyzed, such as particle size, collection location, and specimen owner. The class can appear only once in the label.
*Specimen_Classification Class	The Specimen_Classification class classifies the specimen as to its composition and physical state. The class can appear only once in the label.
*measurement_segments	The measurement_segments attribute gives the number of individual spectra that were combined to create the final merged spectrum. If the spectrum is not merged from multiple segments, then the value of measurement_segments is 1. There will be one instance of the Measurement_Parameters class for each segment.

*Measurement_Parameters Class	The Measurement_Parameters class contains attributes that describe the conditions under which a spectral measurement was made. There will be one instance of the Measurement_Parameters class for each segment of the spectrum.
Ancillary_Product Class	The Ancillary_Product class points to an ancillary data product that contains additional data about the specimen (for example, an XRD measurement or an image of the specimen). This class can appear more than once, or may not appear at all.

4.2 Class <speclib:Specimen_Parameters>

The **Specimen_Parameters** class identifies and describes the laboratory specimen that is the target of the spectral measurement.

The class is expressed in the label as shown below. This class has no subclasses.

```

<speclib:Spectral_Library_Product>
. . .
<speclib:Specimen_Parameters>
  <speclib:specimen_id>
    [identifier unique within the Spectral Library]
  </speclib:specimen_id>
  <speclib:specimen_name>[common name]</speclib:specimen_name>
  <speclib:specimen_description>
    [specimen description]
  </speclib:specimen_description>
  <speclib:source_specimen_id>
    [identifier of source specimen from which this one was derived]
  </speclib:source_specimen_id>
  <speclib:specimen_min_size unit="micrometer">
    [minimum size]
  </speclib:specimen_min_size>
  <speclib:specimen_max_size unit="micrometer">
    [maximum size]
  </speclib:specimen_max_size>
  <speclib:specimen_collection_location>
    [location where specimen was collected]
  </speclib:specimen_collection_location>
  <speclib:specimen_owner_location>
    [facility that owns the specimen]
  </speclib:specimen_owner_location>
  <speclib:specimen_owner_name>
    [name of specimen owner]
  </speclib:specimen_owner_name>
</speclib:Specimen_Parameters>
. . .
</speclib:Spectral_Library_Product>

```

The table below describes the components of the **Specimen_Parameters** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Specimen_Parameters Class	
Component	Description

*specimen_id	The specimen_id attribute uniquely identifies the specimen within the Spectral Library.
specimen_name	The specimen_name attribute provides a name or identifier for the specimen. The value is typically assigned by the person who owns the specimen or the person who made the measurement, and is not guaranteed to be unique. There are no formation rules or constraints on the value, only that the name has to be less than 255 characters long.
specimen_description	The specimen_description attribute provides a short description of the specimen up to 300 characters long.
source_specimen_id	The source_specimen_id attribute identifies the source specimen from which the observed specimen is derived.
specimen_min_size	The specimen_min_size attribute identifies the minimum particle size of the observed specimen. Units are specified with the 'unit' XML attribute. Allowable units are 'AU', 'Angstrom', 'cm', 'km', 'm', 'micrometer', 'mm', and 'nm'.
specimen_max_size	The specimen_max_size attribute identifies the maximum particle size of the observed specimen. Units are specified with the 'unit' XML attribute. Allowable units are 'AU', 'Angstrom', 'cm', 'km', 'm', 'micrometer', 'mm', and 'nm'.
*specimen_collection_location	The specimen_collection_location attribute provides the place where the specimen was collected. The attribute may be present but with a null value.
*specimen_owner_location	The specimen_owner_location attribute provides the institution or facility that owns the specimen at the time the measurement is taken. Use the value 'Unknown' if the location is not known.
*specimen_owner_name	The specimen_owner_name attribute identifies the individual or laboratory that owns the specimen at the time the measurement is taken. Use the value 'Unknown' if the owner is not known.
specimen_provider_name	The specimen_provider_name attribute provides the name of the person who provided the specimen for spectral measurement. This could be different from the specimen_owner_name (individual or laboratory).
specimen_thin_section_flag	The specimen_thin_section_flag element indicates whether or not the specimen is a thin section.

4.3 Class <speclib:Specimen_Classification>

The Specimen_Classification class provides information about the type of the specimen that is the target of the spectral measurement.

The class is expressed in the label as shown below. This class has no subclasses.

```

<speclib:Spectral_Library_Product>
. . .
<speclib:Specimen_Classification>
  <speclib:specimen_type>
    [identifier of the origin of specimen]

```

```

</speclib:specimen_type>
<speclib:material_common_name>
  [a name useful for searching]
</speclib:material_common_name>
<speclib:material_origin>[Natural, Synthetic, or Natural-Doped]
</speclib:material_origin>
<speclib:synthetic_type>
  [required if material_origin is synthetic]
</speclib:synthetic_type>
<speclib:material_state>[Solid, Liquid, or Gas]</speclib:material_state>
<speclib:organic_type>
  [Inorganic, Organic, or Mixture]
</speclib:organic_type>
<speclib:material_type>[general type of specimen]</speclib:material_type>
<speclib:material_subtype>
  [more specific material subtype]
</speclib:material_subtype>
<speclib:mineral_type>
  [required if material_type is Mineral]
</speclib:mineral_type>
<speclib:mineral_subtype>
  [more specific mineral subtype]
</speclib:mineral_subtype>
<speclib:rock_type>
  [required if material_type is Rock]
</speclib:rock_type>
<speclib:rock_subtype>
  [more specific rock subtype]
</speclib:rock_subtype>
<speclib:volatile_type>[Poor, Rich, or Unknown]</speclib:volatile_type>
<speclib:synthetic_processing_description>
  [descriptive text]
</speclib:synthetic_processing_description>
</speclib:Specimen_Classification>
. . .
</speclib:Spectral_Library_Product>

```

The table below describes the components of the **Specimen_Classification** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Specimen_Classification Class	
Component	Description
*specimen_type	The specimen_type attribute gives one or two terms that classify the origin of the specimen. Allowable values are 'Terrestrial Sample', 'Lunar Meteorite', 'Mars Meteorite', 'Other Meteorite', 'Returned Lunar Sample', 'Returned Asteroid Sample', and 'Synthetic Sample'. The most common combination of two specimen_types would include synthetic sample for naturally occurring specimen that have been significantly modified. Other values may be added to the dictionary as needed.
material_common_name	The material_common_name attribute gives a specific name of the specimen material that would be useful for searching in a database.

*material_origin	The material_origin attribute specifies whether the specimen is a natural, synthetic material, or natural/doped. The allowable values are 'Natural', 'Synthetic', and 'Natural-Doped'.
synthetic_type (required if material_origin = Synthetic)	The synthetic_type attribute identifies the nature of a synthetic specimen. Possible values are 'Entirely Synthetic', 'Natural and Synthetic', 'From Natural', and 'Hardware'.
*material_state	The material_state attribute identifies the physical state of the specimen. Allowable values are 'Solid', 'Liquid', and 'Gas'.
organic_type	The organic_type attribute identifies the organic type to which the specimen belongs. Allowable values are 'Inorganic', 'Organic', and 'Mixture'.
*material_type	The material_type attribute indicates the general type of the specimen. See the definition in Section 5 for the list of allowed values.
material_subtype	The material_subtype attribute provides an optional descriptor for additional information about the physical state of the specimen, e.g. particulate or nonparticulate. This attribute can appear more than once.
mineral_type (required if material_type = Mineral)	The mineral_type attribute indicates the mineral class for the specimen. See the definition in Section 5 for the list of allowed values. This attribute can appear more than once in the case of a mixture of minerals.
mineral_subtype (optional; allowed if material_type = Mineral)	The mineral_subtype attribute provides for further subdividing the mineral classification. For example, the value could be 'Smectite' if the mineral_type is 'Phyllosilicate'. There is no enumerated list for this attribute. It can appear more than once.
rock_type (required if material_type = Rock)	The rock_type attribute indicates the rock type for the specimen. Possible values are 'Igneous', 'Sedimentary', and 'Metamorphic'.
rock_subtype (optional; allowed if material_type = Rock)	The rock_subtype attribute provides for further subdividing the rock type. For example, the value could be 'Sandstone' if the rock_type is 'Sedimentary'. There is no enumerated list for this attribute. It can appear more than once.
volatile_type	The volatile_type attribute indicates whether the material is volatile-poor (less than 2.0% loss on ignition) or volatile-rich (greater than 2.0% loss on ignition). Possible values are 'Poor', 'Rich', and 'Unknown'.
synthetic_processing_description	The synthetic_processing_description attribute describes how a synthetic specimen was generated. The description can be up to 255 characters long.
specimen_ph	The specimen_ph element provides the pH of the observed specimen.
specimen_dilution_method	The specimen_dilution_method element describes the method by which dilution was conducted.

specimen_solute_standard	The specimen_solute_standard element provides the standard used for the solute.
--------------------------	--

The following rules apply to the use of the **Specimen_Classification** class.

Rule	Description
speclib_classification_rule_solid_material	If material_state is Solid, then the attributes material_type and material_subtype must be present, and material_subtype must include either Particulate or Nonparticulate.
speclib:classification_rule_organic_material	If material_type is Organic, then the attribute organic_type must also be Organic.
speclib_classification_rule_mineral	If material_type is Mineral, then the attribute mineral_type must be present.
speclib_classification_rule_rock	If material_type is Rock, then the attribute rock_type must be present.
speclib_classification_rule_material_subtype	If the attribute material_subtype is present, then the attribute material_type must also be present.
speclib_classification_rule_mineral_subtype	If the attribute mineral_subtype is present, then the attribute mineral_type must also be present.
speclib_classification_rule_rock_subtype	If the attribute rock_subtype is present, then the attribute rock_type must also be present.
speclib_classification_rule_synthetic	If material_origin is Synthetic, then the attribute synthetic_type must be present. If material_origin is not Synthetic, then the attribute synthetic_type must not be present.

4.4 Class <speclib:Measurement_Parameters>

The **Measurement_Parameters** class provides information about the characteristics of the measurement. It includes the subclass **Measurement_Instrument**, which identifies the instrument used to make the measurement. A spectral measurement may be comprised of multiple spectra measured by different instruments. The attribute **measurement_segments** in the **Spectral_Library_Product** superclass gives the number of individual spectra that were combined to create the final merged spectrum. There is one instance of the **Measurement_Parameters** class for each measured spectrum used to create the labeled PDS product. It is most common to have only one **Measurement_Parameters** class.

The class is expressed in the label as shown below. This class has one subclass, **Measurement_Instrument**.

```
<speclib:Spectral_Library_Product>
. . .
<speclib:Measurement_Parameters>
  <speclib:segment_number>[which segment this is]</speclib:segment_number>
  <speclib:Measurement_Instrument>
    <speclib:instrument_name>[name]</speclib:instrument_name>
    <Internal_Reference>
      <lid_reference>[Instrument LID] </lid_reference>
```

```

        <reference_type>is_instrument</reference_type>
    </Internal_Reference>
</speclib:Measurement_Instrument>
<speclib:measurement_type>[e.g., Reflectance]</speclib:measurement_type>
<speclib:spectral_range_parameter_name>
    [e.g., Wavelength]
</speclib:spectral_range_parameter_name>
<speclib:spectral_range_min>[minimum]</speclib:spectral_range_min>
<speclib:spectral_range_max>[maximum]</speclib:spectral_range_max>
<speclib:spectral_range_unit_name>[e.g., nm]
</speclib:spectral_range_unit_name>
<speclib:spectral_sampling_interval_min>
    [minimum]
</speclib:spectral_sampling_interval_min>
<speclib:spectral_sampling_interval_max>
    [maximum]
</speclib:spectral_sampling_interval_max>
<speclib:spectral_sampling_interval_unit>
    [unit]
</speclib:spectral_sampling_interval_unit>
<speclib:spectral_resolution_width_min>
    [minimum]
</speclib:spectral_resolution_width_min>
<speclib:spectral_resolution_width_max>
    [maximum]
</speclib:spectral_resolution_width_max>
<speclib:spectral_resolution_width_unit>
    [unit]
</speclib:spectral_resolution_width_unit>
<speclib:measurement_reference_standard>
    [text]
</speclib:measurement_reference_standard>
<speclib:measurement_geometry_type>
    [e.g., Bidirectional]
</speclib:measurement_geometry_type>
<speclib:incidence_angle unit="deg">[value]</speclib:incidence_angle>
<speclib:emission_angle unit="deg">[value]</speclib:emission_angle>
<speclib:phase_angle unit="deg">[value]</speclib:phase_angle>
<speclib:measurement_source_description>
    [text]
</speclib:measurement_source_description>
<speclib:measurement_atmosphere_pressure>
    [value]
</speclib:measurement_atmosphere_pressure>
<speclib:measurement_atmosphere_temperature>
    [value]
</speclib:measurement_atmosphere_temperature>
<speclib:measurement_atmosphere_relative_humidity>
    [value]
</speclib:measurement_atmosphere_relative_humidity>
<speclib:measurement_atmosphere_description>
    [description]
</speclib:measurement_atmosphere_description>
<speclib:measurement_date_time>
    [YYYY-MM-DDThh:mm:ss]
</speclib:measurement_date_time>
<speclib:data_producer_name>
    [who made the measurement? e.g., RELAB]

```

```

</speclib:data_producer_name>
<speclib:data_provider_name>
    [who submitted the measurement to the Spectral Library?]
</speclib:data_provider_name>
<speclib:measurement_requestor>
    [who requested the measurement?]
</speclib:measurement_requestor>
<speclib:measurement_notes>
    [text]
</speclib:measurement_notes>
</speclib:Measurement_Parameters>
. . .
</speclib:Spectral_Library_Product>

```

The table below describes the components of the **Measurement_Parameters** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Measurement_Parameters Class	
Component	Description
*segment_number	The segment_number attribute identifies which segment of a merged spectrum is described in this Measurement_Parameters class. The first segment is segment_number 1. If the spectrum is not merged from multiple segments, then the value of segment_number is 1.
*Measurement_Instrument	The Measurement_Instrument class identifies which instrument made the measurement.
*measurement_type	The measurement_type attribute identifies the type of spectroscopy performed on a specimen. See Section 5 for the list of allowed values.
*spectral_range_parameter_name	The spectral_range_parameter_name attribute identifies the name of the parameter which determines the sampling interval of the measurement. See Section 5 for the list of allowed values.
*spectral_range_min	The spectral_range_min attribute identifies the minimum value at which a given data item was sampled. For example, a spectrum that was measured in the 0.4 to 3.5 μm range would have a spectral_range_min value of 0.4.
*spectral_range_max	The spectral_range_max attribute identifies the maximum value at which a given data item was sampled. For example, a spectrum that was measured in the 0.4 to 3.5 μm range would have a spectral_range_max value of 3.5.
*spectral_range_unit_name	The spectral_range_unit_name attribute identifies the unit of measure for the values specified by the spectral_range_min and spectral_range_max .
spectral_sampling_interval_min	The spectral_sampling_interval_min attribute identifies the minimum distance between band

	centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.
spectral_sampling_interval_max	The spectral_sampling_interval_max attribute identifies the maximum distance between band centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.
spectral_sampling_interval_unit	The spectral_sampling_interval_unit attribute identifies the unit of measure for the values specified by spectral_sampling_interval_min and spectral_sampling_interval_max .
spectral_resolution_width_min	The spectral_resolution_width_min attribute identifies the full width at half minimum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.
spectral_resolution_width_max	The spectral_resolution_width_max attribute identifies the full width at half maximum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.
spectral_resolution_width_unit	The spectral_resolution_width_unit attribute identifies the unit of measure for the values specified by spectral_resolution_width_min and spectral_resolution_width_max .
measurement_reference_standard	The measurement_reference_standard attribute describes the standard object on which observations are performed in order to calibrate a measurement.
measurement_geometry_type	The measurement_geometry_type attribute identifies the type of geometry at which a measurement is taken. See Section 5 for the list of allowed values.
incidence_angle	The incidence_angle attribute provides the angle between the local vertical at the intercept point and a vector from the intercept point to the illumination source. The value must be between 0 and 90 degrees, or the attribute may be present with a null value.
emission_angle	The emission_angle attribute provides the angle between the local vertical at the intercept point

	and a vector from the intercept point to the detector. The value must be between 0 and 90 degrees, or the attribute may be present with a null value.
phase_angle	The phase_angle attribute provides the angle between incidence and emission vectors. The value must be between 0 and 180 degrees, or the attribute may be present with a null value.
measurement_source_description	The measurement_source_description attribute identifies the source used for the measurement such as the type of lamp, heating element, laser, or radioactive source.
measurement_atmosphere_pressure	The measurement_atmosphere_pressure attribute provides the atmospheric pressure of measurement environment. Allowable units for this attribute are 'Pa', 'bar', 'hPa', and 'mbar'.
measurement_atmosphere_temperature	The measurement_atmosphere_temperature attribute provides the temperature of the measurement environment. Allowable units for this attribute are 'K' and 'degC'.
measurement_atmosphere_relative_humidity	The measurement_atmosphere_relative_humidity attribute provides the relative humidity of the measurement environment. The attribute may be present with a null value.
measurement_atmosphere_composition	The measurement_atmosphere_composition attribute identifies any gas or gases present in measurement environment.
measurement_atmosphere_description	The measurement_atmosphere_description attribute describes the atmospheric conditions with which the data was taken.
measurement_date_time	The measurement_date_time attribute identifies the date and time when the measurement was made. The attribute may be present with a null value.
*data_producer_name	The data_producer_name element provides the name of the creator of the product.
*data_provider_name	The data_provider_name attribute provides the full name of the person who submitted the measurement to the library.
measurement_requestor	The measurement_requestor attribute provides the full name of the person who requested the measurement to be made. The attribute may be present with a null value. A maximum of two names are permitted to allow for potentially a PI and student, in case of some RELAB measurements.

microscope_objective	The microscope_objective attribute provides the magnification power of the objective lens by power (e.g. 4x, 10x).
measurement_notes	The measurement_notes attribute contains relevant notes about how a measurement was made, up to 1000 characters.
accumulation_time	The accumulation_time is the duration for which a measurement was acquired. If more than one measurement is reported, this value corresponds to the total measurement time across all measurements.
dark_subtraction_flag	The dark_subtraction_flag element indicates if a spectrum has been dark subtracted. Y or N for yes and no are the permissible values.
laser_attenuation	The laser_attenuation element is the energy of the laser pulse used for sample ablation.
laser_averaged_integrations	The laser_averaged_integrations element indicates the number of laser integrations that are averaged. A value of 1 means that the integrations are not averaged.
laser_integrations_saturated	The laser_integrations_saturated element lists the number of spectra with at least one peak that saturates the spectrometer.
laser_power_for_calibration_max	The laser_power_for_calibration_max is the maximum laser power, in percent, used during calibration.
laser_power_for_calibration_min	The laser_power_for_calibration_min is the minimum laser power, in percent, used during calibration.
laser_power_sample	The laser_power_sample is the laser power, in percent, utilized during sample analysis.
laser_pulses_discarded	The laser_pulses_discarded element indicates the number of laser pulses discarded.
laser_pulses_per_integration	The laser_pulses_per_integration element identifies the number of laser pulses per integration. This value is 1 for single shot spectra.
laser_pulse_rate	The laser_pulse_rate element indicates the frequency of laser pulses. A laser_pulse_rate of 10 Hz means that the laser fires ten times per second.
laser_wavelength	The laser_wavelength element indicates the laser wavelength utilized in sample analysis.
measurement_location_number	The measurement_location_number element indicates the location number of spectra collection on the target surface.
measurement_locations_per_sample	The measurement_locations_per_sample element indicates the number of measurement locations per sample.

measurement_run	The measurement_run element identifies the run number of the measurement in a particular day.
-----------------	--

4.5 Class <speclib:Measurement_Instrument>

Measurement_Instrument is a subclass of **Measurement_Parameters**. It identifies the spectrometer that made the measurement by its Logical Identifier (LID).

The class is expressed in the label as shown below. This class has one subclass, **Internal_Reference**, which is defined in the PDS Core Dictionary.

```

<speclib:Spectral_Library_Product>
  . . .
  <speclib:Measurement_Parameters>
    . . .
    <speclib:Measurement_Instrument>
      <speclib:instrument_name>
        [instrument name]
      </speclib:instrument_name>
      <Internal_Reference>
        <lid_reference>
          [instrument LID]
        </lid_reference>
        <reference_type>is_instrument</reference_type>
      </Internal_Reference>
    </speclib:Measurement_Instrument>
  . . .
</speclib:Measurement_Parameters>
. . .
</speclib:Spectral_Library_Product>

```

The table below describes the components of the **Measurement_Instrument** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Measurement_Instrument Class	
Component	Description
*instrument_name	The instrument_name attribute provides a descriptive name of the instrument that made a spectral measurement.
*Internal_Reference	The Internal_Reference class contains the following two attributes that identify the instrument. Note that this class is defined in the PDS core data dictionary, not the Spectral Library data dictionary (i.e., it lacks the 'speclib:' prefix).
*lid_reference	The lid_reference attribute gives the unique PDS4 Logical Identifier (LID) of the instrument that made the measurement.
*reference_type	The reference_type attribute specifies that the LID refers to an instrument. The value of this attribute must be 'is_instrument'.

4.6 Class <speclib:Ancillary_Product>

The **Ancillary_Product** class is optional. A spectral measurement may be accompanied by one or more ancillary products, which may be images of the specimen, plots of the measurement, or other types of measurements of the specimen. This class identifies an ancillary product by its Logical Identifier (LID).

The class is expressed in the label as shown below. This class has one subclass, **Internal_Reference**, which is defined in the PDS Core Dictionary.

```
<speclib:Spectral_Library_Product>
. . .
  <speclib:Ancillary_Product>
    <Internal_Reference>
      <lid_reference>
        urn:nasa:pds:relab:data_ancillary_image:rm-rem-137_on9mmdish
      </lid_reference>
      <reference_type>data_to_ancillary</reference_type>
    </Internal_Reference>
    <speclib:ancillary_product_type>
      Image
    </speclib:ancillary_product_type>
  </speclib:Ancillary_Product>
. . .
</speclib:Spectral_Library_Product>
```

The table below describes the components of the **Ancillary_Product** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Ancillary_Product Class	
Component	Description
*Internal_Reference	The Internal_Reference class contains the following two attributes that identify the ancillary product. Note that this class is defined in the PDS core data dictionary, not the Spectral Library data dictionary (i.e., it lacks the ‘speclib:’ prefix).
*lid_reference	The lid_reference attribute gives the unique PDS4 Logical Identifier (LID) of an ancillary product related to this product.
*reference_type	The reference_type attribute specifies that the LID refers to an ancillary product. The value of this attribute must be ‘data_to_ancillary’.
*ancillary_product_type	The ancillary_product_type attribute gives the type of data in the ancillary product. See Section 5 for the list of allowed values. Additional values may be added to the dictionary.

5 Definitions

Complete definitions of Spectral Library classes and attributes are given here in alphabetical order.

accumulation_time (attribute)

Definition	The duration for which a measurement was acquired. If more than one measurement is reported, this value corresponds to the total measurement time across all measurements.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	*

Ancillary_Product (class)		
Definition	The Ancillary_Product class identifies an ancillary measurement related to a Spectral Library specimen.	
Min/max occurrences in label	0	1

ancillary_product_type (attribute)		
Definition	The ancillary_product_type element provides the type of data found in an ancillary product.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Allowed values	Attenuated Total Reflectance Spectroscopy	IR spectroscopic technique in which placing a sample next to a high refractive index crystal causes total internal reflection resulting in an evanescent wave that samples shallow properties of the sample
	Image	An image of the sample
	Chemical Composition	Elemental or oxide abundances for samples
	Differential Scanning Calorimetry	Technique in which the sample is heated and temperature is monitored to evaluate exothermic and endothermic reactions that are indicative of composition
	Electron Microprobe Analysis	Microprobe technique in which the sample is bombarded with electrons, with resultant X-ray emission spectra indicative of sample composition
	Modal Mineralogy	Sample mineral abundances defined as weight or volume percentages
	Raman Spectroscopy	Spectroscopic technique based on based on inelastic

	scattering of monochromatic light, usually from a laser source
Reflectance Spectroscopy	Spectroscopic technique based on measuring the spectral properties of light scattered from samples
Thermogravimetric Analysis	Technique in which sample mass is measured as its temperature is increased
Transmission Spectroscopy	Spectroscopic technique based on measuring the spectral properties of light transmitted through samples
X-ray Diffraction	X-rays diffracted by a sample as a function of incident angle are used to determine sample crystal structure
X-ray Fluorescence	Spectroscopic technique in which the sample is bombarded by high-energy X-rays or gamma rays, with fluorescent X-ray emission spectra indicative of sample composition

dark_subtraction_flag (attribute)		
Definition	The dark_subtraction_flag element indicates if a spectrum has been dark subtracted.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nilable?	no	
Allowed values	Y	Yes, the spectrum was dark subtracted.
	N	No, the spectrum was not dark subtracted.

data_producer_name (attribute)		
Definition	The data_producer_name element provides the name of the creator of the product.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1

Nilable?	no	
Min/max characters	1	255
Allowed values	any	

data_provider_name (attribute)		
Definition	The data_provider_name element provides the full name of the person who submitted the product to the Spectral Library.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max characters	1	255
Allowed values	any	

emission_angle (attribute)		
Definition	The emission_angle element provides the angle between the local vertical at the intercept point and a vector from the intercept point to the sensor.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nilable?	yes	
Min/max values	-90	90

incidence_angle (attribute)		
Definition	The incidence_angle element provides the angle between the local vertical at the intercept point and a vector from the intercept point to the source.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nilable?	yes	
Min/max values	-90	90

instrument_name (attribute)		
Definition	The instrument_name element provides a descriptive name of the instrument that made a spectral measurement.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max characters	1	100
Allowed values	any	

laser_attenuation (attribute)	
Definition	The laser_attenuation element is the energy of the laser pulse used for sample ablation.

PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	

laser_averaged_integrations (attribute)		
Definition	The laser_averaged_integrations element indicates the number of laser integrations that are averaged. A value of 1 means that the integrations are not averaged.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	1	*

laser_integrations_saturated (attribute)		
Definition	The laser_integrations_saturated element lists the number of spectra with at least one peak that saturates the spectrometer.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	1	*

laser_power_for_calibration_max (attribute)		
Definition	The laser_power_for_calibration_max element lists the maximum laser power, in percent, used during calibration.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	100

laser_power_for_calibration_min (attribute)		
Definition	The laser_power_for_calibration_min element lists the minimum laser power, in percent, used during calibration..	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	100

laser_power_sample (attribute)		
Definition	The laser_power_sample element lists the laser power, in percent, utilized during sample analysis..	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	

Min/max values	0	100
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laser_pulses_discarded (attribute)

Definition	The laser_pulses_discarded element indicates the number of laser pulses discarded.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	*

laser_pulses_per_integration (attribute)

Definition	The laser_pulses_per_integration element identifies the number of laser pulses per integration. This value is 1 for single shot spectra.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	*

laser_pulse_rate (attribute)

Definition	The laser_pulse_rate element indicates the frequency of laser pulses. A laser_pulse_rate of 10 Hz means that the laser fires ten times per second.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	1	*

laser_wavelength (attribute)

Definition	The laser_wavelength element lists the laser wavelength utilized in sample analysis.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	*

material_common_name (attribute)

Definition	The material_common_name element gives the specific name of the specimen material, as specifically as it is known. For example, if a specimen is pure olivine, put "Olivine". If a specimen is a mixture of kaolinite and opal, put "Kaolinite/Opal". Indicate if "Unidentified".	
PDS4 data type	UTF8_Short_String_Collapsed	

Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	100
Allowed values	any	

material_origin (attribute)		
Definition	The material_origin element identifies whether the specimen is natural, synthetic, or natural/doped.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Allowed values	Natural	The Natural value indicates that the specimen was not made in a laboratory.
	Synthetic	The Synthetic value indicates that the specimen or some portion of a specimen was manufactured, laboratory-generated, or naturally occurring sample that has been significantly modified (e.g. heating irradiation). Grinding and stirring alone do not count as significantly modified.
	Natural-Doped	The Natural-Doped value indicates natural rock matrices that have been doped with metal oxides.

material_state (attribute)		
Definition	The material_state element identifies the physical state of the specimen.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Allowed values	Solid	The Solid value indicates that the specimen is in the solid state.
	Liquid	The Liquid value indicates that the specimen is in the liquid state.
	Gas	The Gas value indicates that the specimen is in the gas state.

material_subtype (attribute)		
Definition	The material_subtype element provides an optional descriptor for additional information about the physical state of the specimen, e.g. particulate or nonparticulate.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	10
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

material_type (attribute)		
Definition	The material_type element indicates the general type of the specimen.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Allowed values	Amorphous	Sample without crystalline structure or long range order, e.g., glass
	Consolidated Mixture	Sample that is cemented or otherwise aggregated into a solid mass
	Element	Sample composed of a single element such as metallic iron
	Ice	Solid sample composed of gas or liquid (e.g., water vapor or water) now in solid form
	Mineral	Sample with a given composition within a defined range of compositions and that exhibits a defined crystalline structure
	Organic	Sample composed of organic materials
	Rock	Solid sample composed of one or more minerals
	Single Particle	Sample composed of a single particle
	Unconsolidated Mixture	Sample of loose or disaggregated material that is a mixture of various minerals and/or other compounds

measurement_atmosphere_composition (attribute)
--

Definition	The measurement_atmosphere_composition element identifies any gas(es) present in measurement environment.	
PDS4 data type	UTF8_Text_Preserved	
Min/max occurrences in class	0	1
Nilable?	yes	
Min/max characters	1	1000
Allowed values	any	

measurement_atmosphere_description (attribute)

Definition	The measurement_atmosphere_description describes the atmospheric conditions through which the data was taken.	
PDS4 data type	UTF8_Text_Preserved	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max characters	1	1000
Allowed values	any	

measurement_atmosphere_pressure (attribute)

Definition	The measurement_atmosphere_pressure element provides the atmospheric pressure of the measurement environment.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nilable?	yes	
Min/max values	unlimited	unlimited
PDS4 unit type	Units_of_Pressure	

measurement_atmosphere_relative_humidity(attribute)

Definition	The measurement_atmosphere_relative_humidity element provides the relative humidity of the measurement environment.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nilable?	yes	
Min/max values	0	100

measurement_atmosphere_temperature (attribute)

Definition	The measurement_atmosphere_temperature element provides the temperature of the measurement environment.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nilable?	yes	
Min/max values	unlimited	unlimited
PDS4 unit type	Units_of_Temperature	

measurement_date_time (attribute)		
Definition	The measurement_date_time element identifies the date and time of the observation and measurement.	
PDS4 data type	ASCII_Date_Time_YMD	
Min/max occurrences in class	1	1
Nullable?	yes	
Allowed values	Formation rule <i>yyyymmddThh:mm:ss.nnnnnnZ</i> . The value may be truncated on the right as far as the year. The Z (UTC time indicator) is optional.	

measurement_geometry_type (attribute)		
Definition	The measurement_geometry_type element identifies the type of lighting and viewing geometry at which a measurement is taken.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Allowed values	Bidirectional	Measurement taken when light is sent in to the specimen at a narrow angular range and received over a narrow angular range.
	Directional Hemispherical	Measurement taken when light is sent in to the specimen at a certain direction and received in all directions (perhaps in an integrating sphere).
	Hemispherical Hemispherical	Measurement taken when light is sent in to the specimen at all directions and received in all directions (perhaps in an integrating sphere).
	Biconical	Measurement taken when light is sent in to the specimen at a certain direction and in a cone-like shape and received at a certain direction and in a cone-like shape.
	Unknown	The measurement geometry is unknown.

Measurement_Instrument (class)	
Definition	The Measurement_Instrument class identifies which instrument made the measurement described in the Measurement_Parameters class.

Min/max occurrences in class	1 per Measurement_Parameters class
-------------------------------------	------------------------------------

measurement_location_number (attribute)	
Definition	The measurement_location_number element indicates the location number of spectra collection on the target surface.
PDS4 data type	ASCII_NonNegative_Integer
Min/max occurrences in class	0 1
Nilable?	no
Min/max values	1 *

measurement_locations_per_sample (attribute)	
Definition	The measurement_locations_per_sample element indicates the number of measurement locations per sample.
PDS4 data type	ASCII_NonNegative_Integer
Min/max occurrences in class	0 1
Nilable?	no
Min/max values	0 *

measurement_notes (attribute)	
Definition	The measurement_notes element contains relevant notes about how a measurement was made.
PDS4 data type	UTF8_Text_Preserved
Min/max occurrences in class	0 1
Nilable?	no
Min/max characters	1 1000
Allowed values	any

Measurement_Parameters (class)	
Definition	The Measurement_Parameters class contains attributes relevant to a single measurement of a specimen.
Min/max occurrences in class	Value given by attribute measurement_segments

measurement_reference_standard (attribute)	
Definition	The measurement_reference_standard element identifies the standard object on which observations are performed in order to calibrate a measurement.
PDS4 data type	UTF8_Text_Preserved
Min/max occurrences in class	0 1
Nilable?	no
Min/max characters	1 1000
Allowed values	any

measurement_requestor (attribute)		
Definition	The measurement_requestor element identifies the individual or laboratory who requested the measurement. It may occur up to two times.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	2
Nullable?	yes	
Min/max characters	1	255
Allowed values	any	

measurement_run (attribute)		
Definition	The measurement_run element identifies the run number of the measurement in a particular day.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	1	*

measurement_segments (attribute)		
Definition	The measurement_segments are the number of individual spectra that were combined to create the final merged spectrum. If the spectrum is not merged from multiple spectra, then the value of measurement_segments is 1.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	1	1
Nullable?	no	
Min/max values	1	Unlimited

measurement_source_description (attribute)		
Definition	The measurement_source_description element identifies the source used for the measurement such as the type of lamp, heating element, laser, or radioactive source.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

measurement_type (attribute)		
Definition	The measurement_type element identifies the type of spectroscopy performed on a specimen.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1

Niltable?	no	
Allowed values	Reflectance	The Reflectance value indicates reflectance spectroscopy, the study of light as a function of wavelength that has been reflected or scattered from a material.
	Emission	The Emission value indicates emission spectroscopy, which examines the wavelengths emitted by atoms or molecules during their transition from an excited state to a lower energy state.
	Raman	The Raman value indicates Raman spectroscopy, which determines information about a material by studying the Raman scattering of monochromatic light off the material.
	X-Ray Fluorescence	The X-Ray Fluorescence value indicates x-ray fluorescence spectroscopy, which examines the emission of x-rays from a material previously bombarded with high energy x-rays or gamma rays.
	X-Ray Diffraction	The X-Ray Diffraction value indicates x-ray diffraction spectroscopy, which studies the diffraction patterns of x-rays scattered off a material.
	LIBS	LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra.
	Transmission	The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material.

	Attenuated Total Reflectance	Attenuated total reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further preparation.
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microscope_objective (attribute)		
Definition	The microscope_objective is the magnification power of the objective lens by power (e.g. 4x, 10x).	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	0	1
Nullable?	yes	

mineral_subtype (attribute)		
Definition	The mineral_subtype element provides for further subdividing of specimens identified as minerals. For example, the value could be 'Smectite' if the mineral_type is 'Phyllosilicate'. There is no enumerated list for mineral_subtype. The element may appear more than once.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	10
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

mineral_type (attribute)		
Definition	The mineral_type element identifies the type of mineral to which the specimen belongs. The element may appear more than once.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	Unlimited
Nullable?	no	
Allowed values	Arsenate	
	Borate	
	Carbonate	
	Chromate	
	Cyclosilicate	
	Halide	
	Hydroxide	
	Inosilicate	
	Iodate	
	Native Element	Native element or alloy

Neosilicate	
Nitrate	
Organic Compound	
Oxide	
Phosphate	
Phyllosilicate	
Sorosilicate	
Sulfate	
Sulfide	
Tectosilicate	
Unclassified	For a specimen that doesn't fit into any of the categories, but is still a mineral
Vanadate	

organic_type (attribute)		
Definition	The organic_type element identifies the organic type to which the specimen belongs.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Allowed values	Organic	The Organic value indicates the specimen is an organic material.
	Inorganic	The Inorganic value indicates the specimen is not an organic material.
	Mixture	The Mixture value indicates the specimen is a mixture of organic and inorganic material.

phase_angle (attribute)		
Definition	The phase_angle element provides the angle between incidence and emission vectors.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nullable?	yes	
Min/max values	-180	180
PDS4 unit type	Units_of_Angle	

processing_description (attribute)	
Definition	The processing_description element provides information about how measurement(s) for a particular product were made, in addition to the information given in the Measurement Parameters class. In the case of a product created by merging

	multiple measurements, this element describes how the merge was done.	
PDS4 data type	UTF8_Text_Preserved	
Min/max occurrences in class	0	1
Nilable?	no	
Min/max characters	1	Unlimited
Allowed values	any	

rock_subtype (attribute)		
Definition	The rock_subtype element provides for further subdividing of specimens identified as rocks. For example, the value could be 'Sandstone' if the rock_type is 'Sedimentary'. There is no enumerated list for rock_subtype. The element may appear more than once.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	10
Nilable?	no	
Min/max characters	1	255
Allowed values	any	

rock_type (attribute)		
Definition	The rock_type element identifies the type of rock the specimen is.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nilable?	no	
Allowed values	Igneous	The Igneous value indicates that the specimen is volatile-poor and was formed by the cooling of magma or lava.
	Sedimentary	The Sedimentary value indicates that the specimen was formed by sedimentary processes (e.g., lithification of unconsolidated material, direct chemical precipitation).
	Metamorphic	The Metamorphic value indicates that the specimen was formed by metamorphic processes (e.g., increased temperature and/or pressure conditions that altered the rock composition without melting)

	Unknown	The Unknown value indicates that there is not enough information about the specimen to assign it a rock type
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segment_number (attribute)		
Definition	The segment_number element identifies which segment of a merged spectrum is described by a Measurement_Parameters class. The first segment is segment number 1. If the spectrum is not merged from multiple segments, then the value of segment_number is 1.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max values	1	Unlimited

source_specimen_id (attribute)		
Definition	The source_specimen_id element identifies the source specimen from which the observed specimen is derived, if any.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nilable?	yes	
Min/max characters	1	255
Allowed values	any specimen_id value	

Specimen_Classification (class)		
Definition	The Specimen_Classification Class provides information about how a specimen has been classified by its composition and physical state.	
Min/max occurrences in class	1	1

specimen_collection_location (attribute)		
Definition	The specimen_collection_location element provides the place where the specimen was collected.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nilable?	yes	
Min/max characters	1	255
Allowed values	any	

specimen_description (attribute)		
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Definition	The specimen_description element provides an optional short description of the specimen.	
PDS4 data type	UTF8_Text_Preserved	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	1000
Allowed values	any	

specimen_dilution_method (attribute)

Definition	The specimen_dilution_method element describes the method by which dilution was conducted.	
PDS4 data type	UTF8_Text_Preserved	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	1000
Allowed values	any	

specimen_id (attribute)

Definition	The specimen_id element uniquely identifies the specimen within the Spectral Library. Note that this identifier is not a PDS LID (Logical Identifier), as specimens are not PDS products.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_max_size (attribute)

Definition	The specimen_max_size element identifies the maximum particle size of the observed specimen.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	Unlimited
PDS4 unit type	Units_of_Length	

specimen_min_size (attribute)

Definition	The specimen_min_size element identifies the minimum particle size of the observed specimen.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max values	0	Unlimited
PDS4 unit type	Units_of_Length	

specimen_name (attribute)		
Definition	The specimen_name element identifies the specimen as it is named where it is being kept.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_owner_location (attribute)		
Definition	The specimen_owner_location element provides the institution or laboratory name where the specimen resides.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	yes	
Min/max characters	1	255
Allowed values	any	

specimen_owner_name (attribute)		
Definition	The specimen_owner_name element identifies the individual or laboratory to whom the specimen belongs.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nullable?	yes	
Min/max characters	1	255
Allowed values	any	

Specimen_Parameters (class)		
Definition	The Specimen_Parameters class provides information about a specimen for which measurements have been made.	
Min/max occurrences in class	1	1

specimen_ph (attribute)		
Definition	The specimen_ph element provides the pH of the observed specimen.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Nullable?	no	
Allowed values	0 - 14	

specimen_provider_name (attribute)		
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Definition	The specimen_provider_name element gives the name of the person who provided the specimen for spectral measurement.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_solute_standard (attribute)

Definition	The specimen_solute_standard element provides the standard used for the solute.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_thin_section_flag (attribute)

Definition	The specimen_thin_section_flag element indicates whether or not the specimen is a thin section.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	no	
Allowed values	Y	Yes, the specimen is a thin section.
	N	No, the specimen is not a thin section.

specimen_type (attribute)

Definition	The specimen_type element gives one or more terms that classify the origin of the specimen. The most common combination of two specimen_types would include synthetic sample for naturally occurring specimen that have been significantly modified.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	2
Nullable?	no	
Allowed values	Terrestrial Sample	The Terrestrial value means the specimen is a terrestrial sample originating on Earth.
	Lunar Meteorite	The Lunar Meteorite value means the specimen is a sample from a lunar meteorite.

Mars Meteorite	The Mars Meteorite value means the specimen is a sample from a Mars meteorite.
Other Meteorite	The Other Meteorite value means the specimen is a sample from a meteorite that is not a lunar or Mars meteorite.
Returned Lunar Sample	The Returned Lunar Sample value means the specimen is a lunar sample returned by a mission.
Returned Asteroid Sample	The Returned Asteroid Sample value means the specimen is an asteroid sample returned by a mission.
Synthetic Sample	The Synthetic Sample value means the specimen is manufactured, laboratory-generated, or a naturally occurring sample that has been significantly modified (e.g. heating, irradiation). Grinding and stirring alone do not count as significantly modified.

Spectral_Library_Product (class)		
Definition	The Spectral_Library_Product class provides information about a data product in the Spectral Library.	
Min/max occurrences in class	1	1

spectral_range_max (attribute)		
Definition	The spectral_range_max element identifies the maximum value at which a given data item was sampled. For example, a spectrum that was measured in the 0.4 to 3.5 um spectral range would have a spectral_range_max value of 3.5.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nullable?	no	
Min/max values	0	Unlimited

spectral_range_min (attribute)		
Definition	The spectral_range_min element identifies the minimum value at which a given data item was sampled. For example, a	

	spectrum that was measured in the 0.4 to 3.5 um spectral range would have a spectral_range_min value of 0.4.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max values	0	Unlimited

spectral_range_parameter_name (attribute)		
Definition	The spectral_range_parameter_name element identifies the name of the parameter which determines the sampling interval of the measurement.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nilable?	no	
Allowed values	Wavelength	The spectrum is a function of wavelength.
	Frequency	The spectrum is a function of frequency.
	Wavenumber	The spectrum is a function of wavenumber.
	Time	The spectrum is a function of time.
	Angle	The spectrum is a function of angle.
	Energy	The spectrum is a function of energy.

spectral_range_unit_name (attribute)		
Definition	The spectral_range_unit_name element identifies the unit of measure for the values specified by spectral_range_min and spectral_range_max.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	1	1
Nilable?	no	
Min/max characters	1	255
Allowed values	any	

spectral_resolution_width_max (attribute)		
Definition	The spectral_resolution_width_max element identifies the full width at half maximum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1

Niltable?	yes	
Min/max values	0	Unlimited

spectral_resolution_width_min (attribute)

Definition	The spectral_resolution_width_min element identifies the full width at half minimum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Niltable?	yes	
Min/max values	0	Unlimited

spectral_resolution_width_unit (attribute)

Definition	The spectral_resolution_width_unit element identifies the unit of measure for the values specified by spectral_resolution_width_min and spectral_resolution_width_max.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Niltable?	yes	
Min/max characters	1	255
Allowed values	any	

spectral_sampling_interval_max (attribute)

Definition	The spectral_sampling_interval_max element identifies the maximum distance between band centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1
Niltable?	yes	
Min/max values	0	Unlimited

spectral_sampling_interval_min (attribute)

Definition	The spectral_sampling_interval_min element identifies the minimum distance between band centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurrences in class	0	1

Niltable?	yes	
Min/max values	0	Unlimited

spectral_sampling_interval_unit (attribute)		
Definition	The spectral_sampling_interval_unit element identifies the unit of measure for the values specified by spectral_sampling_interval_min and spectral_sampling_interval_max.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Niltable?	yes	
Min/max characters	1	255
Allowed values	any	

synthetic_processing_description (attribute)		
Definition	The synthetic_processing_description element describes how a synthetic specimen has been processed.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Niltable?	no	
Min/max characters	1	255
Allowed values	any	

synthetic_type (attribute)		
Definition	The synthetic_type element identifies the process by which the specimen was produced synthetically.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Niltable?	no	
Allowed values	Entirely Synthetic	The sample is entirely human-made. If a mixture, no component in the mixture was natural.
	Natural and Synthetic	The sample is a mixture of human-made and naturally occurring components.
	From Natural	A natural product chemically or mineralogically altered by a laboratory treatment (e.g., heating). Does <u>not</u> include size and magnetic separates of natural samples or washing by water.
	Hardware	Portions of an instrument, e.g., portions of a spectrometer

	that contribute to a spectroscopic signature and thus need to be characterized.
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volatile_type (attribute)		
Definition	The volatile_type element indicates whether the material was volatile-poor (less than 2.0% loss on ignition) or volatile-rich (greater than 2.0% loss on ignition).	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurrences in class	0	1
Nullable?	yes	
Allowed values	Poor	The Poor value indicates the specimen had less than 2.0% loss on ignition (LOI).
	Rich	The Rich value indicates the specimen had greater than 2.0% loss on ignition (LOI).
	Unknown	The Unknown value indicates the specimen's volatile type is unknown.

6 Example

The example below shows the Spectral Library part of a label for an actual product, with attribute and class names in blue text, attribute values in black text, and attribute qualifiers in orange and brown.

```
<?xml version="1.0" encoding="UTF-8"?>
<?xml-model . . . ?>
<?xml-model . . . ?>
<Product_Observational . . . >
  <Identification_Area>
    . . .
  </Identification_Area>
  <Observation_Area>
    . . .
    <Discipline_Area>
      <speclib:Spectral_Library_Product>
        <speclib:Specimen_Parameters>
          <speclib:specimen_id>RM-REM-137</speclib:specimen_id>
          <speclib:specimen_name>
            Hisingerite 70080 Gillinge &lt;45 um</speclib:specimen_name>
          <speclib:specimen_description>
            Silicate (Phyllo) , Hisingerite, Vis-NIR and XRD study
            of clay minerals on Mars (MDAP)
          </speclib:specimen_description>
          <speclib:specimen_min_size unit="micrometer">
            0</speclib:specimen_min_size>
          <speclib:specimen_max_size unit="micrometer">
            45</speclib:specimen_max_size>
        </speclib:Specimen_Parameters>
      </speclib:Spectral_Library_Product>
    </Discipline_Area>
  </Observation_Area>
</Product_Observational>
```



```

    <speclib:specimen_collection_location>
      Gillinge, Sweden</speclib:specimen_collection_location>
    <speclib:specimen_owner_location>
      Brown University</speclib:specimen_owner_location>
    <speclib:specimen_owner_name xsi:nil="true" nilReason="unknown"/>
  </speclib:Specimen_Parameters>
  <speclib:Specimen_Classification>
    <speclib:specimen_type>Terrestrial Sample</speclib:specimen_type>
    <speclib:material_origin>Natural</speclib:material_origin>
    <speclib:material_state>Solid</speclib:material_state>
    <speclib:organic_type>Inorganic</speclib:organic_type>
    <speclib:material_type>Mineral</speclib:material_type>
    <speclib:material_subtype>Particulate</speclib:material_subtype>
    <speclib:material_subtype>
      Particulate Ground Sorted</speclib:material_subtype>
    <speclib:mineral_type>Phyllosilicate</speclib:mineral_type>
  </speclib:Specimen_Classification>
  <speclib:measurement_segments>1</speclib:measurement_segments>
  <speclib:Measurement_Parameters>
    <speclib:segment_number>1</speclib:segment_number>
    <speclib:Measurement_Instrument>
      <speclib:instrument_name>
        RELAB Bidirectional Spectrometer</speclib:instrument_name>
      <Internal_Reference>
        <lid_reference>
          urn:nasa:pds:context:instrument:facility.bd-vnir.relab
        </lid_reference>
        <reference_type>is_instrument</reference_type>
      </Internal_Reference>
    </speclib:Measurement_Instrument>
    <speclib:measurement_type>Reflectance</speclib:measurement_type>
    <speclib:spectral_range_parameter_name>
      Wavelength</speclib:spectral_range_parameter_name>
    <speclib:spectral_range_min>300</speclib:spectral_range_min>
    <speclib:spectral_range_max>2600</speclib:spectral_range_max>
    <speclib:spectral_range_unit_name>nm</speclib:spectral_range_unit_name>
    <speclib:measurement_geometry_type>
      Bidirectional</speclib:measurement_geometry_type>
    <speclib:incidence_angle unit="deg">30</speclib:incidence_angle>
    <speclib:emission_angle unit="deg">30</speclib:emission_angle>
    <speclib:phase_angle unit="deg">30</speclib:phase_angle>
    <speclib:measurement_atmosphere_relative_humidity xsi:nil="true"
      nilReason="unknown"/>
    <speclib:measurement_atmosphere_description>
      Ambient</speclib:measurement_atmosphere_description>
    <speclib:measurement_date_time>
      2012-12-14</speclib:measurement_date_time>
    <speclib:data_producer_name>RELAB</speclib:data_producer_name>
    <speclib:data_provider_name>RELAB</speclib:data_provider_name>
    <speclib:measurement_requestor>REM</speclib:measurement_requestor>
    <speclib:measurement_requestor>RM</speclib:measurement_requestor>
  </speclib:Measurement_Parameters>
  <speclib:Ancillary_Product>
    <Internal_Reference>
      <lid_reference>
        urn:nasa:pds:relab:data_ancillary_image:RM-REM-137_On9mmDish
      </lid_reference>
      <reference_type>data_to_ancillary</reference_type>
    </Internal_Reference>
  </speclib:Ancillary_Product>

```

```

        </Internal_Reference>
        <speclib:ancillary_product_type>
            Image</speclib:ancillary_product_type>
        </speclib:Ancillary_Product>
    </speclib:Spectral_Library_Product>
</Discipline_Area>
</Observation_Area>
<File_Area_Observational>
    . . .
</File_Area_Observational>
</Product_Observational>

```